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Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	8051
Core Size	8-Bit
Speed	33MHz
Connectivity	UART/USART
Peripherals	POR
Number of I/O	32
Program Memory Size	-
Program Memory Type	ROMIess
EEPROM Size	-
RAM Size	256 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	-
Oscillator Type	Internal
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	44-LCC (J-Lead)
Supplier Device Package	44-PLCC (16.59x16.59)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/p80c32ubaa-512

Philips Semiconductors Product specification

80C51 8-bit microcontroller family 128/256 byte RAM ROMless low voltage (2.7V-5.5V), low power, high speed (33 MHz)

80C31/80C32

DESCRIPTION

The Philips 80C31/32 is a high-performance static 80C51 design fabricated with Philips high-density CMOS technology with operation from 2.7 V to 5.5 V.

The 80C31/32 ROMless devices contain a 128 \times 8 RAM/256 \times 8 RAM, 32 I/O lines, three 16-bit counter/timers, a six-source, four-priority level nested interrupt structure, a serial I/O port for either multi-processor communications, I/O expansion or full duplex UART, and on-chip oscillator and clock circuits.

In addition, the device is a low power static design which offers a wide range of operating frequencies down to zero. Two software selectable modes of power reduction—idle mode and power-down mode are available. The idle mode freezes the CPU while allowing the RAM, timers, serial port, and interrupt system to continue functioning. The power-down mode saves the RAM contents but freezes the oscillator, causing all other chip functions to be inoperative. Since the design is static, the clock can be stopped without loss of user data and then the execution resumed from the point the clock was stopped.

SELECTION TABLE

For applications requiring more ROM and RAM, see the 8XC54/58 and 8XC51RA+/RB+/RC+/80C51RA+ data sheet.

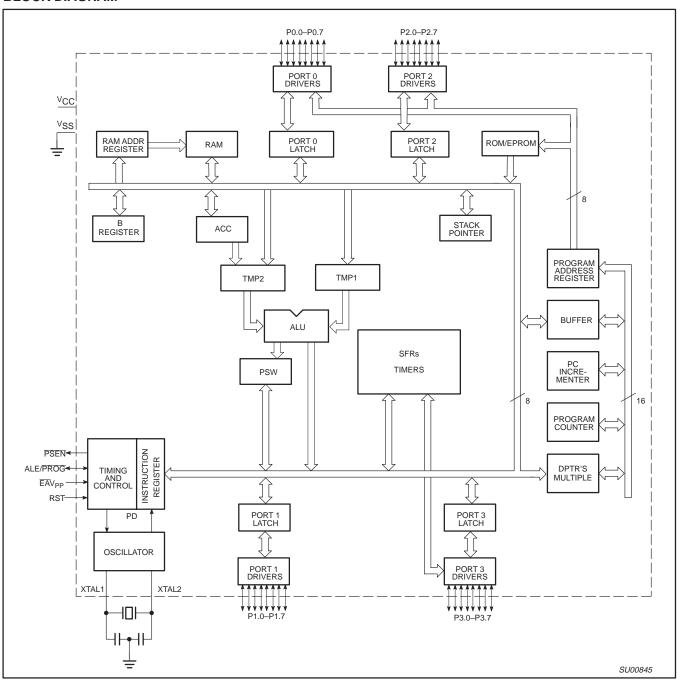
ROM/EPROM Memory Size (X by 8)	RAM Size (X by 8)	Programmable Timer Counter (PCA)	Hardware Watch Dog Timer			
80C31/8XC51						
0K/4K	128	No	No			
80C32/8XC52/54	/58					
0K/8K/16K/32K	256	No	No			
80C51RA+/8XC5	1RA+/RB+/RC	+				
0K/8K/16K/32K	512	Yes	Yes			
8XC51RD+						
64K	1024	Yes	Yes			

FEATURES

- 8051 Central Processing Unit
- 128 × 8 RAM (80C31)
- 256 × 8 RAM (80C32)
- Three 16-bit counter/timers
- Boolean processor
- Full static operation
- Low voltage (2.7 V to 5.5 V@ 16 MHz) operation
- Memory addressing capability
 - 64k ROM and 64k RAM
- Power control modes:
- Clock can be stopped and resumed
- Idle mode
- Power-down mode
- CMOS and TTL compatible
- TWO speed ranges at V_{CC} = 5 V
 - 0 to 16 MHz
 - 0 to 33 MHz
- Three package styles
- Extended temperature ranges
- Dual Data Pointers
- 4 level priority interrupt
- 6 interrupt sources
- Four 8-bit I/O ports
- Full-duplex enhanced UART
 - Framing error detection
 - Automatic address recognition
- Programmable clock out
- Asynchronous port reset
- Low EMI (inhibit ALE)
- Wake-up from Power Down by an external interrupt

80C31/80C32

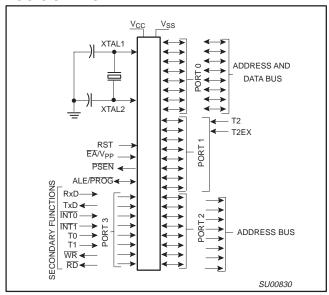
BLOCK DIAGRAM



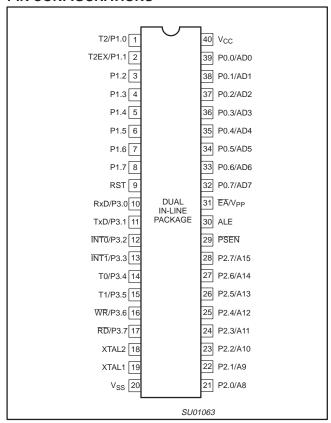
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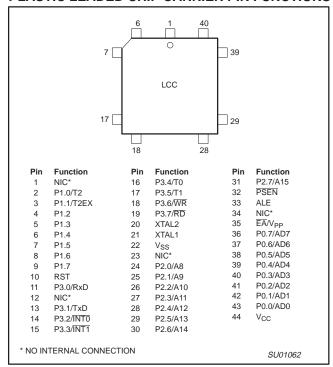
LOGIC SYMBOL



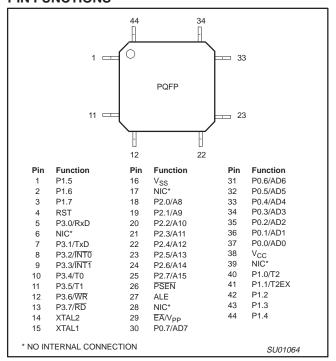
PIN CONFIGURATIONS



PLASTIC LEADED CHIP CARRIER PIN FUNCTIONS



PLASTIC QUAD FLAT PACK PIN FUNCTIONS



80C31/80C32

PIN DESCRIPTIONS

	PI	N NUMB	ER		
MNEMONIC	DIP	LCC	QFP	TYPE	NAME AND FUNCTION
V _{SS}	20	22	16	I	Ground: 0 V reference.
V _{CC}	40	44	38	I	Power Supply: This is the power supply voltage for normal, idle, and power-down operation.
P0.0-0.7	39–32	43–36	37–30	I/O	Port 0: Port 0 is an open-drain, bidirectional I/O port with Schmitt trigger inputs. Port 0 pins that have 1s written to them float and can be used as high-impedance inputs. Port 0 is also the multiplexed low-order address and data bus during accesses to external program and data memory. In this application, it uses strong internal pull-ups when emitting 1s.
P1.0-P1.7	1–8	2–9	40–44, 1–3	I/O	Port 1: Port 1 is an 8-bit bidirectional I/O port with internal pull-ups and Schmitt trigger inputs. Port 1 pins that have 1s written to them are pulled high by the internal pull-ups and can be used as inputs. As inputs, port 1 pins that are externally pulled low will source current because of the internal pull-ups. (See DC Electrical Characteristics: I _{IL}). Alternate functions for Port 1 include:
	1	2	40	I/O	T2 (P1.0): Timer/Counter 2 external count input/clockout (see Programmable Clock-Out)
	2	3	41	I	T2EX (P1.1): Timer/Counter 2 Reload/Capture/Direction control
P2.0-P2.7	21–28	24–31	18–25	I/O	Port 2: Port 2 is an 8-bit bidirectional I/O port with internal pull-ups and Schmitt trigger inputs. Port 2 pins that have 1s written to them are pulled high by the internal pull-ups and can be used as inputs. As inputs, port 2 pins that are externally being pulled low will source current because of the internal pull-ups. (See DC Electrical Characteristics: I _{IL}). Port 2 emits the high-order address byte during fetches from external program memory and during accesses to external data memory that use 16-bit addresses (MOVX @DPTR). In this application, it uses strong internal pull-ups when emitting 1s. During accesses to external data memory that use 8-bit addresses (MOV @Ri), port 2 emits the contents of the P2 special function register.
P3.0-P3.7	10–17	11, 13–19	5, 7–13	I/O	Port 3: Port 3 is an 8-bit bidirectional I/O port with internal pull-ups and Schmitt trigger inputs. Port 3 pins that have 1s written to them are pulled high by the internal pull-ups and can be used as inputs. As inputs, port 3 pins that are externally being pulled low will source current because of the pull-ups. (See DC Electrical Characteristics: I _{IL}). Port 3 also serves the special features of the 80C51 family, as listed below:
	10	11	5	- 1	RxD (P3.0): Serial input port
	11	13	7	0	TxD (P3.1): Serial output port
	12	14	8	I	INTO (P3.2): External interrupt
	13	15	9	!	INT1 (P3.3): External interrupt
	14	16	10		T0 (P3.4): Timer 0 external input
	15 16	17 18	11 12	0	T1 (P3.5): Timer 1 external input WR (P3.6): External data memory write strobe
	17	19	13	0	RD (P3.7): External data memory read strobe
RST	9	10	4	I	Reset: A high on this pin for two machine cycles while the oscillator is running, resets the device. An internal diffused resistor to V _{SS} permits a power-on reset using only an external capacitor to V _{CC} .
ALE	30	33	27	0	Address Latch Enable: Output pulse for latching the low byte of the address during an access to external memory. In normal operation, ALE is emitted at a constant rate of 1/6 the oscillator frequency, and can be used for external timing or clocking. Note that one ALE pulse is skipped during each access to external data memory. ALE can be disabled by setting SFR auxiliary.0. With this bit set, ALE will be active only during a MOVX instruction.
PSEN	29	32	26	0	Program Store Enable: The read strobe to external program memory. When the 80C31/32 is executing code from the external program memory, PSEN is activated twice each machine cycle, except that two PSEN activations are skipped during each access to external data memory. PSEN is not activated during fetches from internal program memory.
EA/V _{PP}	31	35	29	I	External Access Enable/Programming Supply Voltage: EA must be externally held low to enable the device to fetch code from external program memory locations 0000H to 0FFFH.
XTAL1	19	21	15	I	Crystal 1: Input to the inverting oscillator amplifier and input to the internal clock generator circuits.
XTAL2	18	20	14	0	Crystal 2: Output from the inverting oscillator amplifier.

NOTE:

To avoid "latch-up" effect at power-on, the voltage on any pin at any time must not be higher than V_{CC} + 0.5 V or V_{SS} – 0.5 V, respectively.

80C31/80C32

Table 1. 8XC51/80C31 Special Function Registers

SYMBOL	DESCRIPTION	DIRECT ADDRESS	BIT MSB	ADDRES	S, SYMB	OL, OR A	LTERNATI	VE POR	T FUNCT	ION LSB	RESET VALUE
ACC*	Accumulator	E0H	E7	E6	E5	E4	E3	E2	E1	E0	00H
AUXR#	Auxiliary	8EH	-	-	- T	- T	T -	_	-	AO	xxxxxxx0B
AUXR1#	Auxiliary 1	A2H	_	-	-	_	WUPD ²	0	-	DPS	xxx000x0B
B*	B register	F0H	F7	F6	F5	F4	F3	F2	F1	F0	00H
DPTR:	Data Pointer (2 bytes)										
DPH	Data Pointer High	83H									00H
DPL	Data Pointer Low	82H									00H
			AF	AE	AD	AC	AB	AA	A9	A8	
IE*	Interrupt Enable	A8H	EA	-	ET2	ES	ET1	EX1	ET0	EX0	0x000000B
			BF	BE	BD	ВС	BB	ВА	B9	B8	1
IP*	Interrupt Priority	B8H	_	_	PT2	PS	PT1	PX1	PT0	PX0	xx000000B
			B7	B6	B5	B4	В3	B2	B1	B0	1
IPH#	Interrupt Priority High	B7H	_	_	PT2H	PSH	PT1H	PX1H	PT0H	PX0H	xx000000B
	' ' '		87	86	85	84	83	82	81	80	1
P0*	Port 0	80H	AD7	AD6	AD5	AD4	AD3	AD2	AD1	AD0	FFH
			97	96	95	94	93	92	91	90	1
P1*	Port 1	90H		<u> </u>	<u> </u>	<u> </u>	1 -	<u> </u>	T2EX	T2	FFH
			A7	A6	A5	A4	A3	A2	A1	A0	1
P2*	Port 2	A0H	AD15	AD14	AD13	AD12	AD11	AD10	AD9	AD8	FFH
	1 0112	7.011	B7	B6	B5	B4	B3	B2	B1	B0	1
P3*	Port 3	ВОН	RD	WR	T1	T0	INT1	INTO	TxD	RxD	FFH
10	1 011 0		100	***		10	11411	11410	TAB	TOOL	┨
PCON#1	Power Control	87H	SMOD1	SMOD0	<u> </u>	POF	GF1	GF0	PD	IDL	00xx0000B
			D7	D6	D5	D4	D3	D2	D1	D0	1
PSW*	Program Status Word	D0H	CY	AC	F0	RS1	RS0	OV	T -	Р	000000x0B
RACAP2H#	Timer 2 Capture High	СВН		- 110				-			00H
RACAP2L#	Timer 2 Capture Low	CAH									00H
SADDR#	Slave Address	A9H									00H
SADEN#	Slave Address Mask	В9Н									00H
SBUF	Serial Data Buffer	99H									xxxxxxxxB
			9F	9E	9D	9C	9B	9A	99	98	
SCON*	Serial Control	98H	SM0/FE	SM1	SM2	REN	TB8	RB8	TI	RI	00Н
SP	Stack Pointer	81H		l	<u> </u>		<u>I</u>		1		07H
			8F	8E	8D	8C	8B	8A	89	88	
TCON*	Timer Control	88H	TF1	TR1	TF0	TR0	IE1	IT1	IE0	IT0	00H
			CF	CE	CD	CC	СВ	CA	C9	C8	1
T2CON*	Timer 2 Control	C8H	TF2	EXF2	RCLK	TCLK	EXEN2	TR2	C/T2	CP/RL2	00H
T2MOD#	Timer 2 Mode Control	C9H		_	-	-	-	-	T2OE	DCEN	xxxxxx00B
TH0	Timer High 0	8CH								DOLIV	00H
TH1	Timer High 1	8DH									00H
TH2#	Timer High 2	CDH									00H
TL0	Timer Low 0	8AH	1								00H
TL1	Timer Low 1	8BH									00H
TL2#	Timer Low 2	CCH	<u> </u>								00H
TMOD	Timer Mode	89H	GATE	C/T	M1	M0	GATE	C/T	M1	M0	00H

NOTE:

Unused register bits that are not defined should not be set by the user's program. If violated, the device could function incorrectly.

* SFRs are bit addressable.

- # SFRs are modified from or added to the 80C51 SFRs.
- Reserved bits.
- 1. Reset value depends on reset source.
- 2. Not available on 80C31.

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80C31/80C32

OSCILLATOR CHARACTERISTICS

XTAL1 and XTAL2 are the input and output, respectively, of an inverting amplifier. The pins can be configured for use as an on-chip oscillator, as shown in the logic symbol.

To drive the device from an external clock source, XTAL1 should be driven while XTAL2 is left unconnected. There are no requirements on the duty cycle of the external clock signal, because the input to the internal clock circuitry is through a divide-by-two flip-flop. However, minimum and maximum high and low times specified in the data sheet must be observed.

Reset

A reset is accomplished by holding the RST pin high for at least two machine cycles (24 oscillator periods), while the oscillator is running. To insure a good power-up reset, the RST pin must be high long enough to allow the oscillator time to start up (normally a few milliseconds) plus two machine cycles.

Stop Clock Mode

The static design enables the clock speed to be reduced down to 0 MHz (stopped). When the oscillator is stopped, the RAM and Special Function Registers retain their values. This mode allows step-by-step utilization and permits reduced system power consumption by lowering the clock frequency down to any value. For lowest power consumption the Power Down mode is suggested.

Idle Mode

In idle mode (see Table 2), the CPU puts itself to sleep while all of the on-chip peripherals stay active. The instruction to invoke the idle mode is the last instruction executed in the normal operating mode before the idle mode is activated. The CPU contents, the on-chip RAM, and all of the special function registers remain intact during this mode. The idle mode can be terminated either by any enabled interrupt (at which time the process is picked up at the interrupt service routine and continued), or by a hardware reset which starts the processor in the same manner as a power-on reset.

Power-Down Mode

To save even more power, a Power Down mode (see Table 2) can be invoked by software. In this mode, the oscillator is stopped and the instruction that invoked Power Down is the last instruction executed. The on-chip RAM and Special Function Registers retain their values down to 2.0 V and care must be taken to return V_{CC} to the minimum specified operating voltages before the Power Down Mode is terminated.

For the 80C31 or 80C32, either a hardware reset or external interrupt can be used to exit from Power Down. Reset redefines all the SFRs but does not change the on-chip RAM. An external interrupt allows both the SFRs and the on-chip RAM to retain their values. WUPD (AUXR1.3–Wakeup from Power Down) enables or disables the wakeup from power down with external interrupt. Where:

WUPD = 0 Disable WUPD = 1 Enable

To properly terminate Power Down the reset or external interrupt should not be executed before V_{CC} is restored to its normal operating level and must be held active long enough for the oscillator to restart and stabilize (normally less than 10 ms).

With an external interrupt, INT0 or INT1 must be enabled and configured as level-sensitive. Holding the pin low restarts the oscillator but bringing the pin back high completes the exit. Once the interrupt is serviced, the next instruction to be executed after RETI will be the one following the instruction that put the device into Power Down.

For the 80C31, wakeup from power down is always enabled.

Design Consideration

• When the idle mode is terminated by a hardware reset, the device normally resumes program execution, from where it left off, up to two machine cycles before the internal reset algorithm takes control. On-chip hardware inhibits access to internal RAM in this event, but access to the port pins is not inhibited. To eliminate the possibility of an unexpected write when Idle is terminated by reset, the instruction following the one that invokes Idle should not be one that writes to a port pin or to external memory.

ONCE™ Mode

The ONCE ("On-Circuit Emulation") Mode facilitates testing and debugging of systems without the device having to be removed from the circuit. The ONCE Mode is invoked by:

- 1. Pull ALE low while the device is in reset and PSEN is high;
- 2. Hold ALE low as RST is deactivated.

While the device is in ONCE Mode, the Port 0 pins go into a float state, and the other port pins and ALE and PSEN are weakly pulled high. The oscillator circuit remains active. While the 80C31/32 is in this mode, an emulator or test CPU can be used to drive the circuit. Normal operation is restored when a normal reset is applied.

Table 2. External Pin Status During Idle and Power-Down Modes

MODE	PROGRAM MEMORY	ALE	PSEN	PORT 0	PORT 1	PORT 2	PORT 3
Idle	Internal	1	1	Data	Data	Data	Data
Idle	External	1	1	Float	Data	Address	Data
Power-down	Internal	0	0	Data	Data	Data	Data
Power-down	External	0	0	Float	Data	Data	Data

80C31/80C32

Programmable Clock-Out

A 50% duty cycle clock can be programmed to come out on P1.0. This pin, besides being a regular I/O pin, has two alternate functions. It can be programmed:

- 1. to input the external clock for Timer/Counter 2, or
- to output a 50% duty cycle clock ranging from 61 Hz to 4 MHz at a 16 MHz operating frequency.

To configure the Timer/Counter 2 as a clock generator, bit C/T2 (in T2CON) must be cleared and bit T20E in T2MOD must be set. Bit TR2 (T2CON.2) also must be set to start the timer.

The Clock-Out frequency depends on the oscillator frequency and the reload value of Timer 2 capture registers (RCAP2H, RCAP2L) as shown in this equation:

Where:

(RCAP2H,RCAP2L) = the content of RCAP2H and RCAP2L taken as a 16-bit unsigned integer.

In the Clock-Out mode Timer 2 roll-overs will not generate an interrupt. This is similar to when it is used as a baud-rate generator. It is possible to use Timer 2 as a baud-rate generator and a clock generator simultaneously. Note, however, that the baud-rate and the Clock-Out frequency will be the same.

TIMER 2 OPERATION

Timer 2

Timer 2 is a 16-bit Timer/Counter which can operate as either an event timer or an event counter, as selected by $C/\overline{T}2^*$ in the special function register T2CON (see Figure 1). Timer 2 has three operating modes:Capture, Auto-reload (up or down counting) ,and Baud Rate Generator, which are selected by bits in the T2CON as shown in Table 3.

Capture Mode

In the capture mode there are two options which are selected by bit EXEN2 in T2CON. If EXEN2=0, then timer 2 is a 16-bit timer or counter (as selected by C/T2* in T2CON) which, upon overflowing sets bit TF2, the timer 2 overflow bit. This bit can be used to generate an interrupt (by enabling the Timer 2 interrupt bit in the IE register). If EXEN2= 1, Timer 2 operates as described above, but with the added feature that a 1- to -0 transition at external input T2EX causes the current value in the Timer 2 registers, TL2 and

TH2, to be captured into registers RCAP2L and RCAP2H, respectively. In addition, the transition at T2EX causes bit EXF2 in T2CON to be set, and EXF2 like TF2 can generate an interrupt (which vectors to the same location as Timer 2 overflow interrupt. The Timer 2 interrupt service routine can interrogate TF2 and EXF2 to determine which event caused the interrupt). The capture mode is illustrated in Figure 2 (There is no reload value for TL2 and TH2 in this mode. Even when a capture event occurs from T2EX, the counter keeps on counting T2EX pin transitions or osc/12 pulses.).

Auto-Reload Mode (Up or Down Counter)

In the 16-bit auto-reload mode, Timer 2 can be configured (as either a timer or counter (C/T2* in T2CON)) then programmed to count up or down. The counting direction is determined by bit DCEN (Down Counter Enable) which is located in the T2MOD register (see Figure 3). When reset is applied the DCEN=0 which means Timer 2 will default to counting up. If DCEN bit is set, Timer 2 can count up or down depending on the value of the T2EX pin.

Figure 4 shows Timer 2 which will count up automatically since DCEN=0. In this mode there are two options selected by bit EXEN2 in T2CON register. If EXEN2=0, then Timer 2 counts up to 0FFFFH and sets the TF2 (Overflow Flag) bit upon overflow. This causes the Timer 2 registers to be reloaded with the 16-bit value in RCAP2L and RCAP2H. The values in RCAP2L and RCAP2H are preset by software means.

If EXEN2=1, then a 16-bit reload can be triggered either by an overflow or by a 1-to-0 transition at input T2EX. This transition also sets the EXF2 bit. The Timer 2 interrupt, if enabled, can be generated when either TF2 or EXF2 are 1.

In Figure 5 DCEN=1 which enables Timer 2 to count up or down. This mode allows pin T2EX to control the direction of count. When a logic 1 is applied at pin T2EX Timer 2 will count up. Timer 2 will overflow at 0FFFFH and set the TF2 flag, which can then generate an interrupt, if the interrupt is enabled. This timer overflow also causes the 16-bit value in RCAP2L and RCAP2H to be reloaded into the timer registers TL2 and TH2.

When a logic 0 is applied at pin T2EX this causes Timer 2 to count down. The timer will underflow when TL2 and TH2 become equal to the value stored in RCAP2L and RCAP2H. Timer 2 underflow sets the TF2 flag and causes 0FFFFH to be reloaded into the timer registers TL2 and TH2.

The external flag EXF2 toggles when Timer 2 underflows or overflows. This EXF2 bit can be used as a 17th bit of resolution if needed. The EXF2 flag does not generate an interrupt in this mode of operation.

Table 3. Timer 2 Operating Modes

RCLK + TCLK	CP/RL2	TR2	MODE
0	0	1	16-bit Auto-reload
0	1	1	16-bit Capture
1	Х	1	Baud rate generator
X	Х	0	(off)

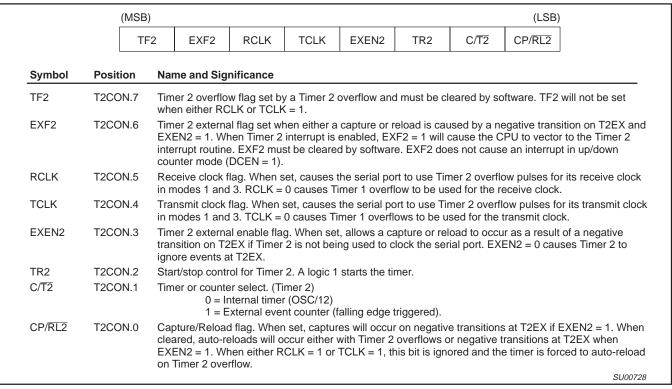


Figure 1. Timer/Counter 2 (T2CON) Control Register

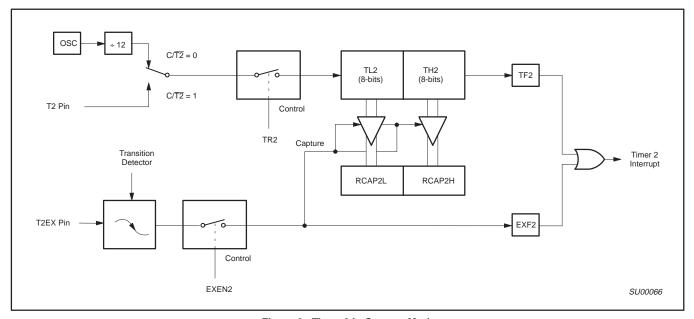


Figure 2. Timer 2 in Capture Mode

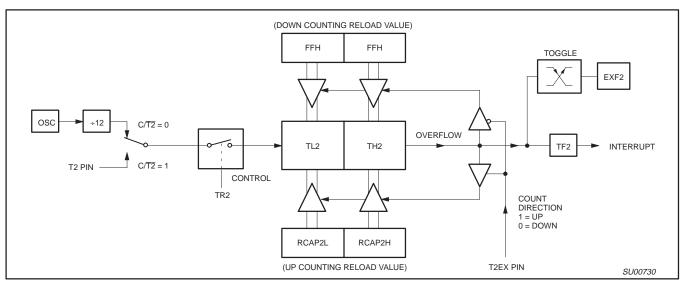


Figure 5. Timer 2 Auto Reload Mode (DCEN = 1)

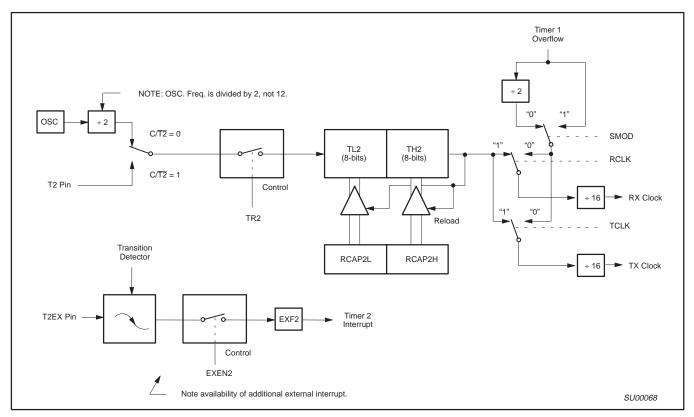


Figure 6. Timer 2 in Baud Rate Generator Mode

80C31/80C32

Interrupt Priority Structure

The 80C31 and 80C32 have a 6-source four-level interrupt structure. They are the IE, IP and IPH. (See Figures 10, 11, and 12.) The IPH (Interrupt Priority High) register that makes the four-level interrupt structure possible. The IPH is located at SFR address B7H. The structure of the IPH register and a description of its bits is shown in Figure 12.

The function of the IPH SFR is simple and when combined with the IP SFR determines the priority of each interrupt. The priority of each interrupt is determined as shown in the following table:

PRIORI	TY BITS	INTERRUPT PRIORITY LEVEL
IPH.x	IP.x	INTERROPT PRIORITI LEVEL
0	0	Level 0 (lowest priority)
0	1	Level 1
1	0	Level 2
1	1	Level 3 (highest priority)

An interrupt will be serviced as long as an interrupt of equal or higher priority is not already being serviced. If an interrupt of equal or higher level priority is being serviced, the new interrupt will wait until it is finished before being serviced. If a lower priority level interrupt is being serviced, it will be stopped and the new interrupt serviced. When the new interrupt is finished, the lower priority level interrupt that was stopped will be completed.

Table 7. Interrupt Table

		_		
SOURCE	POLLING PRIORITY	REQUEST BITS	HARDWARE CLEAR?	VECTOR ADDRESS
X0	1	IE0	N (L) ¹ Y (T) ²	03H
T0	2	TP0	Υ	0BH
X1	3	IE1	N (L) Y (T)	13H
T1	4	TF1	Υ	1BH
SP	5	RI, TI	N	23H
T2	6	TF2, EXF2	N	2BH

NOTES:

- 1. L = Level activated
- 2. T = Transition activated

		7	6	5	4	3	2	1	0
	IE (0A8H)	EA	_	ET2	ES	ET1	EX1	ET0	EX0
			Bit = 1 en Bit = 0 dis	ables the i ables it.	nterrupt.				
BIT	SYMBOL	FUNC	TION						
IE.7	EA					rrupts are earing its			each inte
IE.6	_	Not im	plemente	d. Reserv	ed for futu	ıre use.			
IE.5	ET2	Timer	2 interrup	t enable b	it.				
IE.4	ES	Serial	Port inter	upt enabl	e bit.				
IE.3	ET1	Timer	1 interrup	t enable b	it.				
IE.2	EX1	Extern	al interru	ot 1 enable	e bit.				
IE.1	ET0	Timer	0 interrup	t enable b	it.				
IE.0	EX0	Extern	al interru	ot 0 enable	e bit.				

Figure 10. IE Registers

Philips Semiconductors Product specification

80C51 8-bit microcontroller family 128/256 byte RAM ROMless low voltage (2.7V–5.5V), low power, high speed (33 MHz)

80C31/80C32

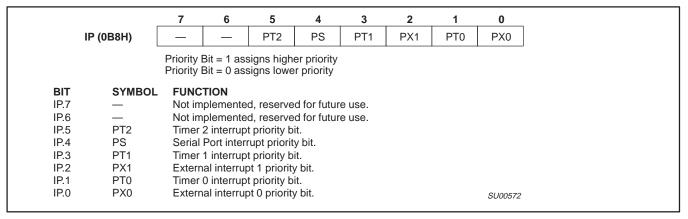


Figure 11. IP Registers

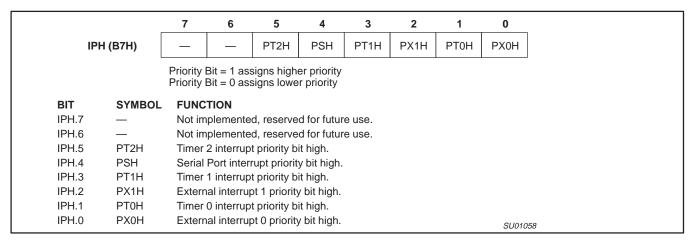


Figure 12. IPH Registers

80C31/80C32

DC ELECTRICAL CHARACTERISTICS

 $T_{amb} = 0^{\circ}C$ to +70°C or -40°C to +85°C, $V_{CC} = 2.7$ V to 5.5 V, $V_{SS} = 0$ V (16 MHz devices)

		TEST		LIMITS		·
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP ¹	MAX	UNIT
M	lanut laurus liana	4.0 V < V _{CC} < 5.5 V	-0.5		0.2 V _{CC} -0.1	V
V_{IL}	Input low voltage	2.7 V <v<sub>CC< 4.0 V</v<sub>	-0.5		0.7	V
V _{IH}	Input high voltage (ports 0, 1, 2, 3, EA)		0.2 V _{CC} +0.9		V _{CC} +0.5	V
V _{IH1}	Input high voltage, XTAL1, RST		0.7 V _{CC}		V _{CC} +0.5	V
V _{OL}	Output low voltage, ports 1, 2, 8	$V_{CC} = 2.7 \text{ V}$ $I_{OL} = 1.6 \text{ mA}^2$			0.4	V
V _{OL1}	Output low voltage, port 0, ALE, PSEN ^{8, 7}	$V_{CC} = 2.7 \text{ V}$ $I_{OL} = 3.2 \text{ mA}^2$			0.4	٧
	Output high purposes 4 0 0 3	V _{CC} = 2.7 V I _{OH} = -20 μA	V _{CC} - 0.7			V
V _{OH}	Output high voltage, ports 1, 2, 3 ³	V _{CC} = 4.5 V I _{OH} = -30 μA	V _{CC} - 0.7			V
V _{OH1}	Output high voltage (port 0 in external bus mode), ALE ⁹ , PSEN ³	$V_{CC} = 2.7 \text{ V}$ $I_{OH} = -3.2 \text{ mA}$	V _{CC} - 0.7			V
I _{IL}	Logical 0 input current, ports 1, 2, 3	V _{IN} = 0.4 V	-1		-50	μΑ
I _{TL}	Logical 1-to-0 transition current, ports 1, 2, 3 ⁶	V _{IN} = 2.0 V See note 4			-650	μА
ILI	Input leakage current, port 0	$0.45 < V_{IN} < V_{CC} - 0.3$			±10	μΑ
Icc	Power supply current (see Figure 21): Active mode @ 16 MHz Idle mode @ 16 MHz Power-down mode or clock stopped (see Figure 25 for conditions)	See note 5 $T_{amb} = 0^{\circ}\text{C to } 70^{\circ}\text{C}$ $T_{amb} = -40^{\circ}\text{C to } +85^{\circ}\text{C}$		3	50 75	μΑ μΑ μΑ μΑ
R _{RST}	Internal reset pull-down resistor		40		225	kΩ
C _{IO}	Pin capacitance ¹⁰ (except EA)				15	pF

NOTES:

- 1. Typical ratings are not guaranteed. The values listed are at room temperature, 5 V.
- Capacitive loading on ports 0 and 2 may cause spurious noise to be superimposed on the Vols of ALE and ports 1 and 3. The noise is due to external bus capacitance discharging into the port 0 and port 2 pins when these pins make 1-to-0 transitions during bus operations. In the worst cases (capacitive loading > 100 pF), the noise pulse on the ALE pin may exceed 0.8 V. In such cases, it may be desirable to qualify ALE with a Schmitt Trigger, or use an address latch with a Schmitt Trigger STROBE input. IoL can exceed these conditions provided that no single output sinks more than 5 mA and no more than two outputs exceed the test conditions
- 3. Capacitive loading on ports 0 and 2 may cause the V_{OH} on ALE and \overline{PSEN} to momentarily fall below the V_{CC} -0.7 specification when the address bits are stabilizing.
- Pins of ports 1, 2 and 3 source a transition current when they are being externally driven from 1 to 0. The transition current reaches its maximum value when V_{IN} is approximately 2 V.
- See Figures 22 through 25 for I_{CC} test conditions.

 $I_{CC} = 0.9 \times FREQ. + 1.1 \text{ mA}$

- Idle mode: $I_{CC} = 0.18 \times FREQ. +1.01$ mA; See Figure 21. 6. This value applies to $T_{amb} = 0^{\circ}C$ to $+70^{\circ}C$. For $T_{amb} = -40^{\circ}C$ to $+85^{\circ}C$, $I_{TL} = -750$ μ A.
- Load capacitance for port 0, ALE, and PSEN = 100 pF, load capacitance for all other outputs = 80 pF.
- 8. Under steady state (non-transient) conditions, I_{OL} must be externally limited as follows: Maximum I_{OL} per port pin: 15 mA (*NOTE: This is 85°C specification.)

Maximum I_{OL} per 8-bit port: 26 mA

Maximum total I_{OL} for all outputs: 71 mA

If I_{OL} exceeds the test condition, V_{OL} may exceed the related specification. Pins are not guaranteed to sink current greater than the listed test conditions.

- 9. ALE is tested to V_{OH1}, except when ALE is off then V_{OH} is the voltage specification.
- 10. Pin capacitance is characterized but not tested. Pin capacitance is less than 25 pF.

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DC ELECTRICAL CHARACTERISTICS

 $T_{amb} = 0$ °C to +70°C or -40°C to +85°C, 33 MHz devices; 5 V ±10%; $V_{SS} = 0$ V

0)/440-01	24244555	TEST		LIMITS		
SYMBOL	PARAMETER	CONDITIONS	MIN TYP1 MAX -0.5 0.2 V _{CC} -0.1 0.2 V _{CC} +0.9 V _{CC} +0.5 0.7 V _{CC} V _{CC} +0.5 0.4 0.4 V _{CC} - 0.7 -50 -650 +10 3 50 75 75	UNIT		
V _{IL}	Input low voltage	4.5 V < V _{CC} < 5.5 V	-0.5		0.2 V _{CC} -0.1	V
V _{IH}	Input high voltage (ports 0, 1, 2, 3, EA)		0.2 V _{CC} +0.9		V _{CC} +0.5	V
V _{IH1}	Input high voltage, XTAL1, RST		0.7 V _{CC}		V _{CC} +0.5	V
V _{OL}	Output low voltage, ports 1, 2, 3 8	$V_{CC} = 4.5 \text{ V}$ $I_{OL} = 1.6 \text{mA}^2$			0.4	V
V _{OL1}	Output low voltage, port 0, ALE, PSEN 7, 8	$V_{CC} = 4.5 \text{ V}$ $I_{OL} = 3.2 \text{mA}^2$			0.4	V
V _{OH}	Output high voltage, ports 1, 2, 3 ³	$V_{CC} = 4.5 \text{ V}$ $I_{OH} = -30\mu\text{A}$	V _{CC} - 0.7			V
V _{OH1}	Output high voltage (port 0 in external bus mode), ALE ⁹ , PSEN ³	$V_{CC} = 4.5 \text{ V}$ $I_{OH} = -3.2 \text{mA}$	V _{CC} - 0.7			V
I _{IL}	Logical 0 input current, ports 1, 2, 3	V _{IN} = 0.4 V	-1		-50	μΑ
I _{TL}	Logical 1-to-0 transition current, ports 1, 2, 3 ⁶	V _{IN} = 2.0 V See note 4			-650	μА
ILI	Input leakage current, port 0	$0.45 < V_{IN} < V_{CC} - 0.3$			±10	μΑ
I _{CC}	Power supply current (see Figure 21): Active mode (see Note 5) Idle mode (see Note 5)	See note 5				
	Power-down mode or clock stopped (see Fig- ure 25 for conditions)	$T_{amb} = 0^{\circ}C \text{ to } 70^{\circ}C$ $T_{amb} = -40^{\circ}C \text{ to } +85^{\circ}C$		3	1	μA μA
R _{RST}	Internal reset pull-down resistor		40		225	kΩ
C _{IO}	Pin capacitance ¹⁰ (except EA)				15	pF

NOTES:

- 1. Typical ratings are not guaranteed. The values listed are at room temperature, 5 V.
- Capacitive loading on ports 0 and 2 may cause spurious noise to be superimposed on the VOLs of ALE and ports 1 and 3. The noise is due to external bus capacitance discharging into the port 0 and port 2 pins when these pins make 1-to-0 transitions during bus operations. In the worst cases (capacitive loading > 100 pF), the noise pulse on the ALE pin may exceed 0.8 V. In such cases, it may be desirable to qualify ALE with a Schmitt Trigger, or use an address latch with a Schmitt Trigger STROBE input. IOL can exceed these conditions provided that no single output sinks more than 5mA and no more than two outputs exceed the test conditions.
- 3. Capacitive loading on ports 0 and 2 may cause the V_{OH} on ALE and PSEN to momentarily fall below the V_{CC} -0.7 specification when the address bits are stabilizing.
- Pins of ports 1, 2 and 3 source a transition current when they are being externally driven from 1 to 0. The transition current reaches its maximum value when $V_{\mbox{\scriptsize IN}}$ is approximately 2 V.
- 5. See Figures 22 through 25 for I_{CC} test conditions.

- Active mode: I_{CC(MAX)} = 0.9 × FREQ. + 1.1 mA Idle mode: I_{CC(MAX)} = 0.18 × FREQ. +1.0 mA; See Figure 21.

 6. This value applies to T_{amb} = 0°C to +70°C. For T_{amb} = -40°C to +85°C, I_{TL} = -750 μA.
- Load capacitance for port 0, ALE, and $\overline{PSEN} = 100 \text{ pF}$, load capacitance for all other outputs = 80 pF.
- 8. Under steady state (non-transient) conditions, I_{OL} must be externally limited as follows: Maximum IOL per port pin: 15 mA (*NOTE: This is 85°C specification.)

Maximum I_{OL} per 8-bit port: 26 mA

Maximum total I_{OL} for all outputs: 71 mA

If I_{OL} exceeds the test condition, V_{OL} may exceed the related specification. Pins are not guaranteed to sink current greater than the listed test conditions.

- ALE is tested to V_{OH1} , except when ALE is off then V_{OH} is the voltage specification.
- 10. Pin capacitance is characterized but not tested. Pin capacitance is less than 25 pF. Pin capacitance of ceramic package is less than 15 pF (except EA is 25 pF).

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80C31/80C32

AC ELECTRICAL CHARACTERISTICS

 $T_{amb} = 0^{\circ}C$ to +70°C or -40°C to +85°C, $V_{CC} = 5 \text{ V} \pm 10\%$, $V_{SS} = 0 \text{ V}^{1, 2, 3}$

				E CLOCK ⁴			
				to f _{max}		CLOCK	1
SYMBOL	FIGURE	PARAMETER	MIN	MAX	MIN	MAX	UNIT
t _{LHLL}	14	ALE pulse width	2t _{CLCL} -40		21		ns
t _{AVLL}	14	Address valid to ALE low	t _{CLCL} -25		5		ns
t _{LLAX}	14	Address hold after ALE low	t _{CLCL} -25				ns
t _{LLIV}	14	ALE low to valid instruction in		4t _{CLCL} -65		55	ns
t _{LLPL}	14	ALE low to PSEN low	t _{CLCL} -25		5		ns
t _{PLPH}	14	PSEN pulse width	3t _{CLCL} -45		45		ns
t _{PLIV}	14	PSEN low to valid instruction in		3t _{CLCL} -60		30	ns
t _{PXIX}	14	Input instruction hold after PSEN	0		0		ns
t _{PXIZ}	14	Input instruction float after PSEN		t _{CLCL} -25		5	ns
t _{AVIV}	14	Address to valid instruction in		5t _{CLCL} -80		70	ns
t _{PLAZ}	14	PSEN low to address float		10		10	ns
Data Memor	ry	•	•		•		•
t _{RLRH}	15, 16	RD pulse width	6t _{CLCL} -100		82		ns
t _{WLWH}	15, 16	WR pulse width	6t _{CLCL} -100		82		ns
t _{RLDV}	15, 16	RD low to valid data in		5t _{CLCL} -90		60	ns
t _{RHDX}	15, 16	Data hold after RD	0		0		ns
t _{RHDZ}	15, 16	Data float after RD		2t _{CLCL} -28		32	ns
t _{LLDV}	15, 16	ALE low to valid data in		8t _{CLCL} -150		90	ns
t _{AVDV}	15, 16	Address to valid data in		9t _{CLCL} -165		105	ns
t _{LLWL}	15, 16	ALE low to RD or WR low	3t _{CLCL} -50	3t _{CLCL} +50	40	140	ns
t _{AVWL}	15, 16	Address valid to WR low or RD low	4t _{CLCL} -75		45		ns
t _{QVWX}	15, 16	Data valid to WR transition	t _{CLCL} -30		0		ns
t _{WHQX}	15, 16	Data hold after WR	t _{CLCL} -25		5		ns
t _{QVWH}	16	Data valid to WR high	7t _{CLCL} -130		80		ns
t _{RLAZ}	15, 16	RD low to address float	0202	0		0	ns
twhlh	15, 16	RD or WR high to ALE high	t _{CLCL} -25	t _{CLCL} +25	5	55	ns
External Clo	ock		0202	0101			
t _{CHCX}	18	High time	0.38t _{CLCL}	t _{CLCL} -t _{CLCX}			ns
tCLCX	18	Low time	0.38t _{CLCL}	t _{CLCL} -t _{CHCX}			ns
t _{CLCH}	18	Rise time	0202	5			ns
tCHCL	18	Fall time	1	5			ns
Shift Regist		1	-				
t _{XLXL}	17	Serial port clock cycle time	12t _{CLCL}		360		ns
t _{QVXH}	17	Output data setup to clock rising edge	10t _{CLCL} -133		167		ns
t _{XHQX}	17	Output data hold after clock rising edge	2t _{CLCL} -80				ns
t _{XHDX}	17	Input data hold after clock rising edge	0		0		ns
t _{XHDV}	17	Clock rising edge to input data valid	+ -	10t _{CLCL} -133		167	ns

NOTES:

- 1. Parameters are valid over operating temperature range unless otherwise specified.
- 2. Load capacitance for port 0, ALE, and $\overline{PSEN} = 100 \, pF$, load capacitance for all other outputs = 80 pF.
- 3. Interfacing the 80C31 and 80C32 to devices with float times up to 45ns is permitted. This limited bus contention will not cause damage to Port 0 drivers.
- 4. Variable clock is specified for oscillator frequencies greater than 16 MHz to 33 MHz. For frequencies equal or less than 16 MHz, see 16 MHz "AC Electrical Characteristics", page 23.
- 5. Parts are guaranteed to operate down to 0 Hz. When an external clock source is used, the RST pin should be held high for a minimum of 20 μs for power-on or wakeup from power down.

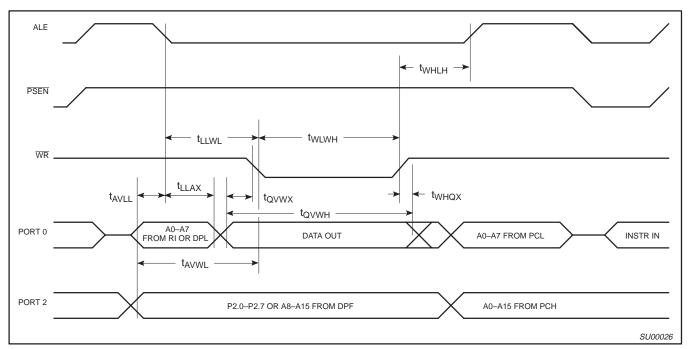


Figure 16. External Data Memory Write Cycle

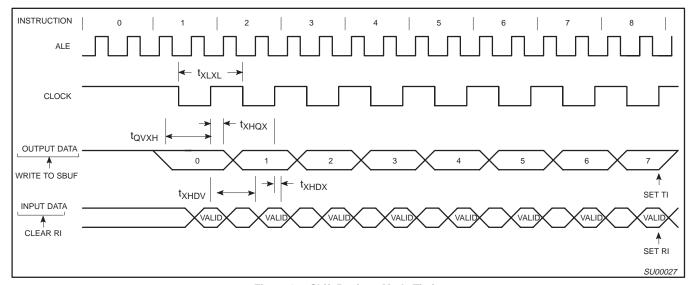


Figure 17. Shift Register Mode Timing

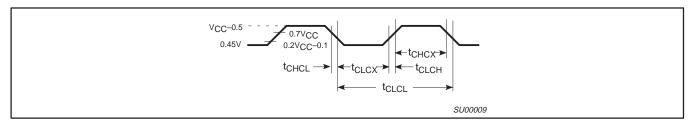


Figure 18. External Clock Drive

Philips Semiconductors Product specification

80C51 8-bit microcontroller family 128/256 byte RAM ROMless low voltage (2.7V–5.5V), low power, high speed (33 MHz)

80C31/80C32

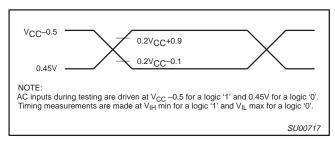


Figure 19. AC Testing Input/Output

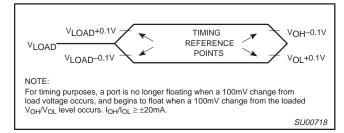
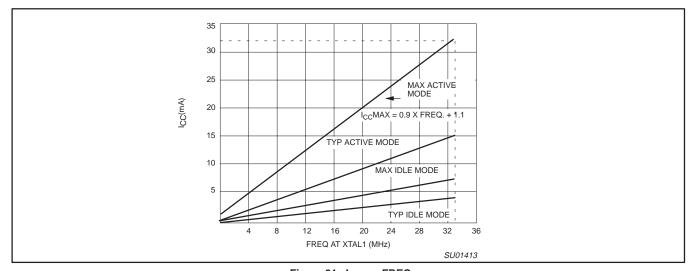


Figure 20. Float Waveform

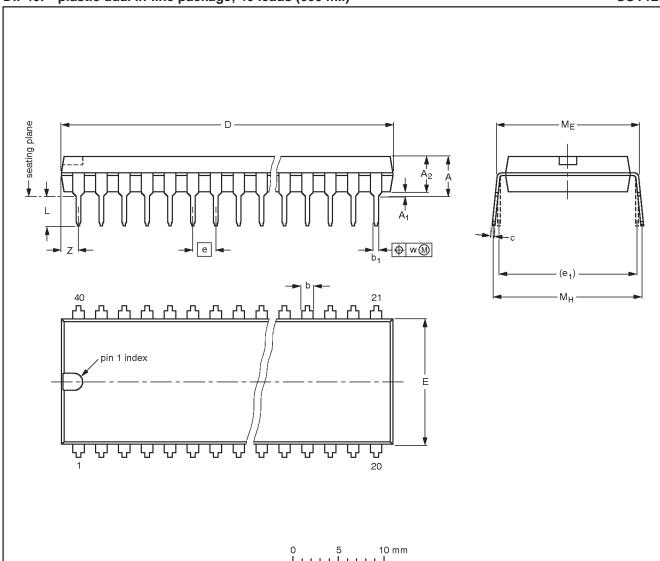


 $\label{eq:continuous} \mbox{Figure 21. I}_{\mbox{CC}} \mbox{ vs. FREQ} \\ \mbox{Valid only within frequency specifications of the device under test}$

80C31/80C32

DIP40: plastic dual in-line package; 40 leads (600 mil)

SOT129-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	С	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	Мн	w	Z ⁽¹⁾ max.
mm	4.7	0.51	4.0	1.70 1.14	0.53 0.38	0.36 0.23	52.50 51.50	14.1 13.7	2.54	15.24	3.60 3.05	15.80 15.24	17.42 15.90	0.254	2.25
inches	0.19	0.020	0.16	0.067 0.045	0.021 0.015	0.014 0.009	2.067 2.028	0.56 0.54	0.10	0.60	0.14 0.12	0.62 0.60	0.69 0.63	0.01	0.089

scale

Note

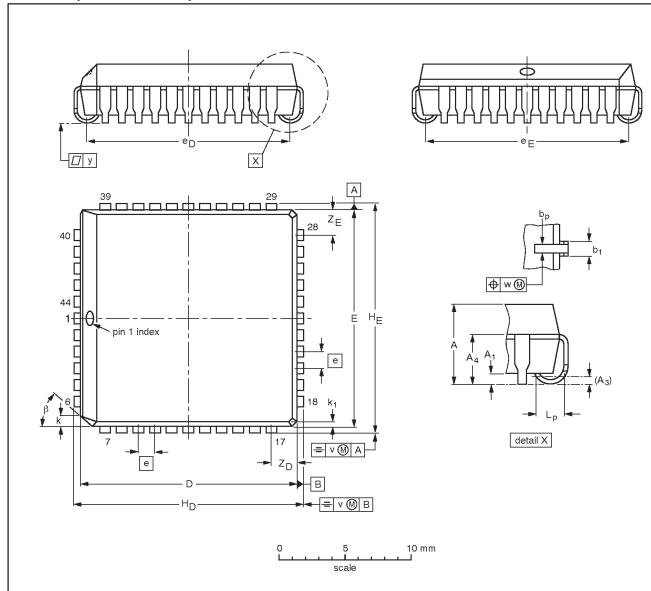
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT129-1	051G08	MO-015	SC-511-40		95-01-14 99-12-27

80C31/80C32

PLCC44: plastic leaded chip carrier; 44 leads

SOT187-2



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	Α	A ₁ min.	A ₃	A ₄ max.	bp	b ₁	D ⁽¹⁾	E ⁽¹⁾	е	e _D	еE	H _D	HE	k	k ₁ max.	Lp	v	w	у		- 1	β
mm	4.57 4.19	0.51	0.25	3.05	0.53 0.33			16.66 16.51		16.00 14.99					0.51	1.44 1.02	0.18	0.18	0.10	2.16	2.16	45 ⁰
inches	0.180 0.165	0.020	0.01			0.032 0.026			0.05	0.630 0.590	0.630 0.590	0.695 0.685	0.695 0.685	0.048 0.042	0.020	0.057 0.040	0.007	0.007	0.004	0.085	0.085	

Note

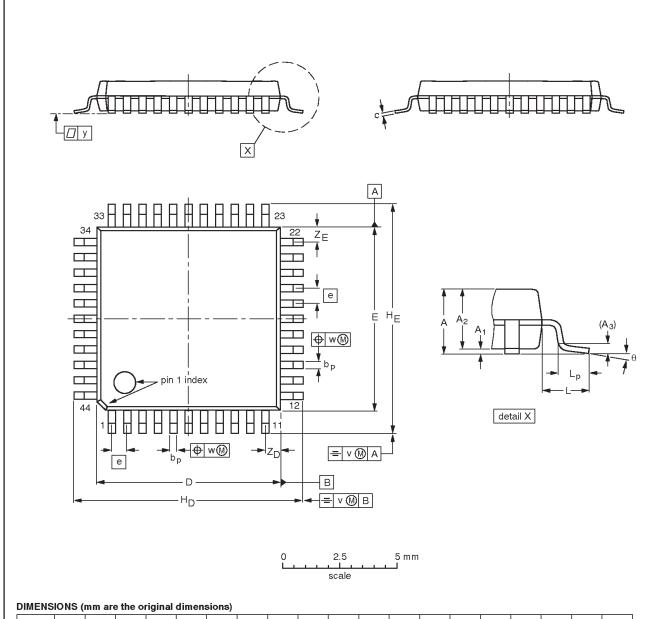
1. Plastic or metal protrusions of 0.01 inches maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	1330E DATE
SOT187-2	112E10	MO-047			97-12-16 99-12-27

80C31/80C32

QFP44: plastic quad flat package; 44 leads (lead length 1.3 mm); body 10 x 10 x 1.75 mm

SOT307-2



UNIT	A max.	Α1	A ₂	A ₃	Ьp	С	D ⁽¹⁾	E ⁽¹⁾	е	H _D	HE	L	Lp	v	w	у	Z _D ⁽¹⁾	Z _E ⁽¹⁾	θ
mm	2.10	0.25 0.05	1.85 1.65	0.25	0.40 0.20	0.25 0.14	10.1 9.9	10.1 9.9	0.8	12.9 12.3	12.9 12.3	1.3	0.95 0.55	0.15	0.15	0.1	1.2 0.8	1.2 0.8	10° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT307-2					-95-02-04 97-08-01

Philips Semiconductors Product specification

80C51 8-bit microcontroller family 128/256 byte RAM ROMless low voltage (2.7V–5.5V), low power, high speed (33 MHz)

80C31/80C32

Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

^[1] Please consult the most recently issued datasheet before initiating or completing a design.

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Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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